



# MJ N-Channel Enhancement Mode Power MOSFET

# Description

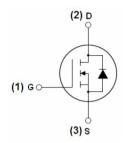
The MJ5520Q uses advanced trench technology and design to provide excellent  $R_{\text{DS}(\text{ON})}$  with low gate charge. It can be used in a wide variety of applications.

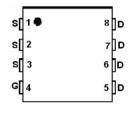
#### General Features

- ♦  $V_{DS}=55V,I_{D}=20A$  $R_{DS(ON)}<22m\Omega$  @  $V_{GS}=10V$  (Typ:19mΩ)
- ◆ High density cell design for ultra low Rdson
- ◆ Fully characterized avalanche voltage and current

## Application

- ◆ Industrial power supplies
- ◆ LED backlighting







Schematic Diagram

Pin assignment

DFN3X3 EP top view

## Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ5520Q	MJ5520Q	DFN3X3EP	-	-	-

# Absolute Maximum Ratings (Tc =25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	Vos	55	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous (Note 1)	lo	20	Α
Drain Current-Continuous(Tc =100°C)	ID(100°C)	14	А
Pulsed Drain Current	Ідм	60	А
Maximum Power Dissipation	Po	35	W
Derating factor		0.23	W/°C
Operating Junction and Storage Temperature Range	Тл ,Твтв	-55 To 150	°C

## Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2)	RөJA	3.6	°C/W
Thermal Resistance, Juniction-to-Case	KθJA	3.6	C/VV





# Electrical Characteristics (TA =25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit		
Off Characteristics								
Drain-Source Breakdown Voltage	BVDSS	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	55	-	-	V		
Zero Gate Voltage Drain Current	loss	V <sub>DS</sub> =55V,V <sub>GS</sub> =0V	-	-	1	μΑ		
Gate-Body Leakage Current	Igss	V <sub>DS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA		
n Characteristics (Note 3)								
Gate Threshold Voltage	VGS(th)	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250µA	2	3	4	V		
Drain-Source On-State Resistance	Rds(on)	V <sub>GS</sub> =10V, I <sub>D</sub> =10A	-	19	22	mΩ		
Dynamic Characteristics (Note 4)	'		'					
Input Capacitance	Ciss		-	1340	-	PF		
Output Capacitance	Coss	V <sub>DS</sub> =25V,V <sub>GS</sub> =0V, F=1.0MHz	-	123	-	PF		
Reverse Transfer Capacitance	Crss		-	10	-	PF		
Switching Characteristics (Note 4)	'							
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =25V,I <sub>D</sub> =2A	-	6	-	nS		
Turn-on Rise Time	tr		_	2.5	-	nS		
Turn-Off Delay Time	td(off)	$R_L=3\Omega,R_G=3\Omega$	_	22	-	nS		
Turn-Off Fall Time	tr		-	2.5	-	nS		
Total Gate Charge	Qg		-	21	-	nC		
Gate-Source Charge	Qgs	V <sub>DS</sub> =25V,I <sub>D</sub> =10A, V <sub>GS</sub> =10V	_	5	-	nC		
Gate-Drain Charge	Qgd	-	-	3	-	nC		
Drain-Source Diode Characteristics					I	1		
Diode Forward Voltage (Note 3)	VsD	V <sub>GS</sub> =0V,I <sub>S</sub> =20A	_	_	1.2	V		
Diode Forward Current (Note 2)	Is		-	-	20	А		
Reverse Recovery Time	trr	TJ=25°C, IF=10A	-	16		nS		
Reverse Recovery Charge	Qrr	di/dt=100A/µs (Note 3)	-	38		nC		
Forward Turn-On Time	ton	Intrinsic turn-on time is n	egligible(tu	ırn-on is d	ominated b	y LS+LD		

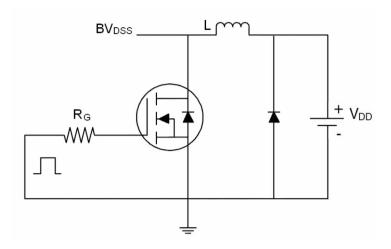
### Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board,  $t \le 10$  sec.
- ③ Pulse Test: Pulse Width ≤ 300 $\mu$ s, Duty Cycle ≤ 2%.
- 4 Guaranteed by design, not subject to production

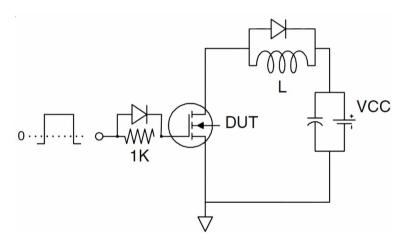




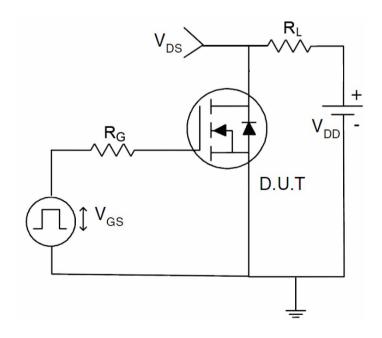
# Test circuit



Eas test Circuit



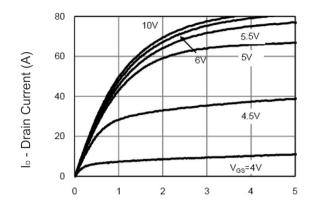
Gate charge test Circuit



Switch Time Test Circuit



# Typical Electrical and Thermal Characteristics (Curves)



Vds Drain-Source Voltage (V) Figure 1 Output Characteristics

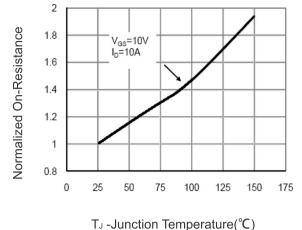
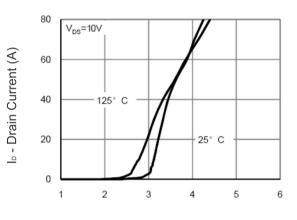


Figure 4 Rdson-Junction Temperature



Vgs Gate-Source Voltage (V) Figure 2 Transfer Characteristics

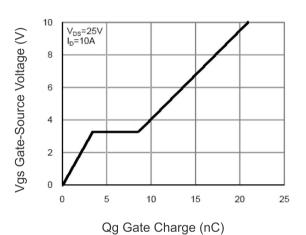


Figure 5 Gate Charge

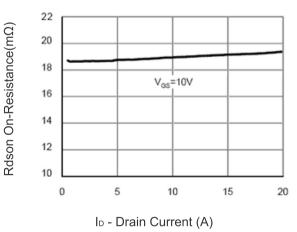
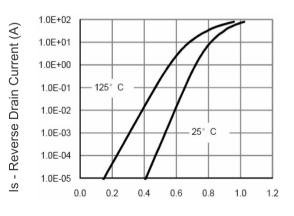


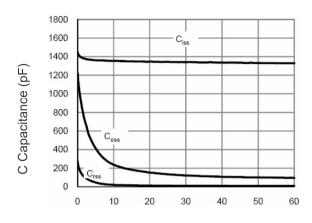
Figure 3 Rdson- Drain Current



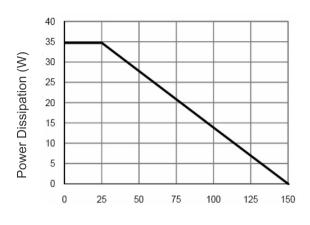
Vsd Source-Drain Voltage (V) Figure 6 Source- Drain Diode Forward







Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds



T<sub>J</sub> -Junction Temperature(°C) Figure 9 Power De-rating

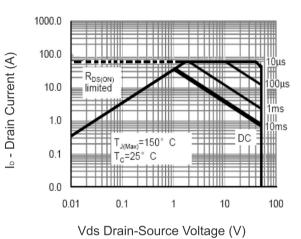
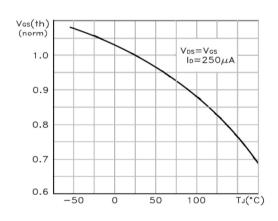


Figure 8 Safe Operation Area



T<sub>J</sub> -Junction Temperature(°C)

Figure 10 V<sub>GS(th)</sub> vs Junction Temperature

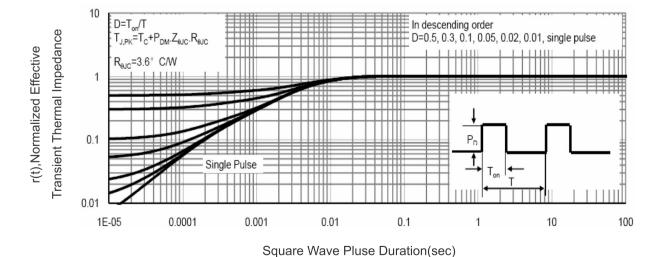
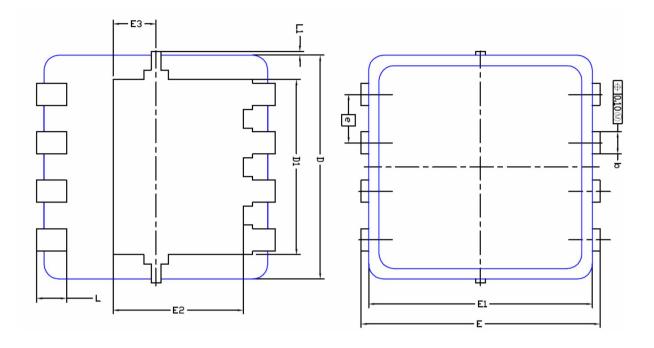


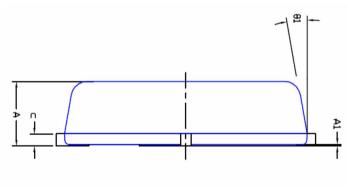
Figure 11 Normalized Maximum Transient Thermal Impedance





# DFN3X3 EP Package Information





DIM.	MILLIMETERS			INCHES				
DIM.	MIN	NDM	MAX	MIN	NDM	MAX		
Α	0.700	0.80	0.900	0.0276	0.0315	0.0354		
A1	0.00		0.05	0.000		0.002		
b	0,24	0,30	0,35	0,009	0.012	0.014		
С	0,10	0,152	0,25	0,004	0,006	0,010		
D	3	3.00 BS	С	0.118 BSC				
D1	2	.35 BS	С	0.	.093 BSC			
E	3	120 BS	С	0.	126 BSC			
E1	(3)	3,00 BS	С	0	0,118 BSC			
E2	1	.75 BS	С	0.	069 BSC			
E3	0.	575 BS	SC	0.023 BSC				
6	0	.65 BS	С	0.	0.026 BSC			
Ĺ	0.30	0.40	0,50	0.0118	0.0157	0.0197		
L1	0		0.100	0		0.004		
81	0°	10°	12°	0*	10°	12*		





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